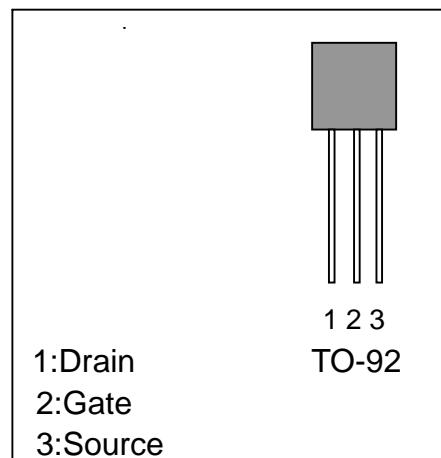


**Apm****JFET****2SK117**

### Low Noise Amplifier Applications

- \*High  $Y_{fs}=15\text{ms}(\text{typ})$  ( $V_{DS}=10\text{V}, V_{GS}=0$ )
- \*High  $V_{GDS}=-30\text{V}$
- \*Low noise:  $NF=1.0\text{dB}(\text{typ})$   
( $V_{DS}=10\text{V}, I_D=0.5\text{mA}, f=1\text{kHz}, R_G=1\text{k}\Omega$ )
- \*High input impedance:  $I_{GSS}=-1\text{nA}, V_{GS}=-30\text{V}$ )

### Silicon N Channel Junction Type



### Absolute Maximum rating at $T_a=25$

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
$V_{GDS}$	Gate-Drain voltage	30		V
$I_G$	Gate current	10		mA
$T_{stg}$	storage temprature	-55	+150	
$T_j$	operating junction temperature	-55	+125	
$P_D$	Drain power dissipation	300		mW

### Electrical Characteristics at $T_a=25$

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
$I_{GSS}$	Gate cut-off current	$V_{GS}=-30\text{V}$			-1.0	nA
$V_{(BR)GDS}$	G-D breakdown voltage	$V_{DS}=0, I_G=-100\mu\text{A}$	-30			V
$I_{DSS}$	Drain current	$V_{DS}=10\text{V}, V_{GS}=0$	1.2		14	mA
$V_{GS(\text{off})}$	G-S cut-off voltage	$V_{DS}=10\text{V}, I_D=0.1\mu\text{A}$	-0.2		-1.5	V
$Y_{fs}$	Forward transfer admittance	$V_{DS}=10\text{V}, V_{GS}=0, f=1\text{kHz}$	4.0	15		mS
$C_{iss}$	Input capacitance	$V_{DS}=10\text{V}, V_{GS}=0, f=1\text{MHz}$		13		pF
$C_{rss}$	Reverse transfer capacitance	$V_{GD}=-10\text{V}, I_D=0, f=1\text{MHz}$		3		pF
NF(1)	Noise figure	$V_{DS}=10\text{v}, R_G=1\text{K}$ $I_D=0.5\text{mA}, f=10\text{Hz}$		5	10	dB
NF(2)	Noise figure	$V_{DS}=10\text{v}, R_G=1\text{K}$ $I_D=0.5\text{mA}, f=1\text{KHz}$		1	2	dB

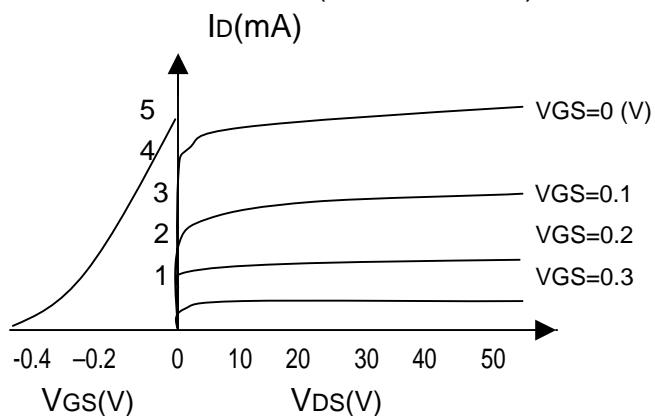
Note: IDSS classification Y:1.2—3.0mA, GR:2.6—6.5mA, BL:6—14mA

**Apm**

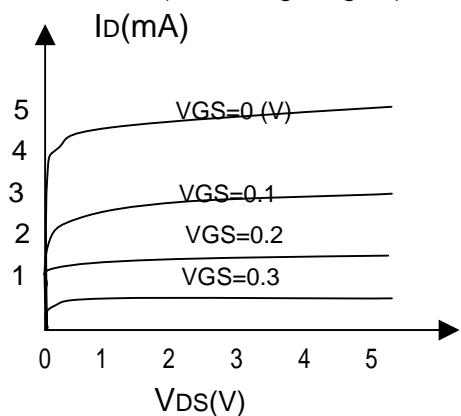
**JFET**

**2SK117**

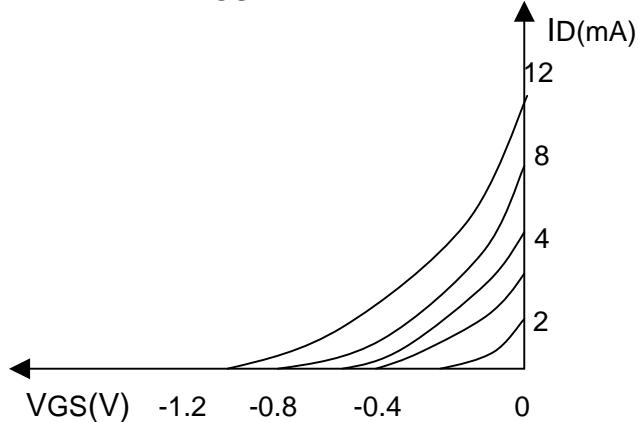
Static characteristics (common source)



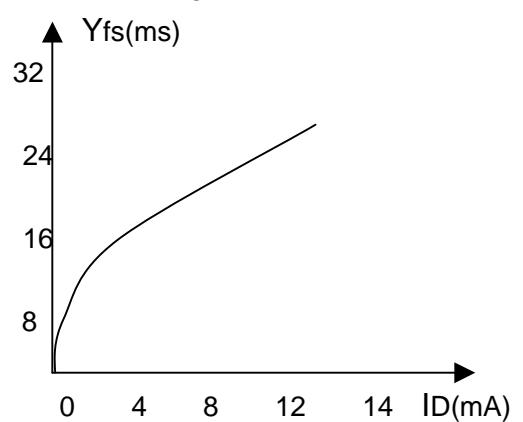
$ID-V_{DS}$ (low voltage region)



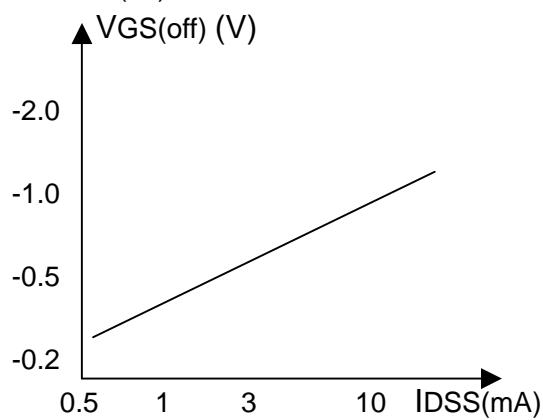
$ID-V_{GS}$



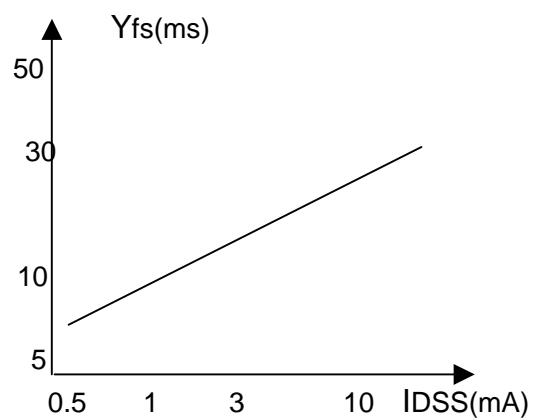
$Y_{fs}-ID$



$V_{GS(\text{off})}-ID_{SS}$



$Y_{fs}-ID_{SS}$



*Apm*

*JFET*

*2SK117*

